Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10593786	KANO ET AL.
Examiner	Art Unit

1647

SEARCHED				
Class	Subclass	Date	Examiner	
NONE		3/25/11	JML	

JON M LOCKARD

SEARCH NOTES				
Search Notes	Date	Examiner		
STIC Search of SEQ ID NOs:1-2. See sequence search results in SCORE.	3/25/11	JML		
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	3/25/11	JML		
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See attached search history.	3/25/11	JML		
PALM: Inventor search.	3/25/11	JML		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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